

REVISIONS			
LTR	DESCRIPTION	DATE	APPROVED
A	Add device type 02. Update boilerplate to current revision. - CFS	06-12-15	Thomas M. Hess
B	Update boilerplate to current MIL-PRF-38535 requirements. - PHN	14-02-18	Thomas M. Hess
C	Under Table I, Temperature coefficients section, Offset drift test, delete 2 ppm of FSR/°C and replace with 0 ppm of FSR/°C. Under Figure 3, Functional block diagram, make correction by deleting DA[13:0], DB[13:0] and replacing with DA[11:0], DB[11:0]. Add Mode of transportation and quantity column. Update document paragraphs to current requirements. - ro	19-11-05	James R. Eschmeyer



CURRENT DESIGN ACTIVITY CAGE CODE 16236  
HAS CHANGED NAMES TO:  
DLA LAND AND MARITIME  
COLUMBUS, OHIO 43218-3990

Prepared in accordance with ASME Y14.24

Vendor item drawing

REV																				
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REV STATUS OF PAGES	REV	C	C	C	C	C	C	C	C	C	C	C	C	C	C	C				
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PMIC N/A	PREPARED BY Phu H. Nguyen	DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43218-3990																		
Original date of drawing YY-MM-DD  06-08-22	CHECKED BY Phu H. Nguyen	TITLE MICROCIRCUIT, DIGITAL-LINEAR, DUAL 12-BIT 200 MSPS DIGITAL TO ANALOG CONVERTER, MONOLITHIC SILICON																		
	APPROVED BY Thomas M. Hess																			
	SIZE A	CODE IDENT. NO. 16236	DWG NO. <b>V62/06651</b>																	
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1. SCOPE

1.1 Scope. This drawing documents the general requirements of a high performance dual 12-bit 200 MSPS digital to analog converter microcircuit, with an operating temperature range of -55°C to +125°C.

1.2 Vendor Item Drawing Administrative Control Number. The manufacturer's PIN is the item of identification. The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation:

<u>V62/06651</u>	-	<u>01</u>	<u>X</u>	<u>E</u>
Drawing number		Device type (See 1.2.1)	Case outline (See 1.2.2)	Lead finish (See 1.2.3)

1.2.1 Device type(s).

<u>Device type</u>	<u>Generic</u>	<u>Circuit function</u>
01	DAC5662-EP	Dual 12-bit 200 MSPS digital to analog converter
02	DAC5662-EP	Dual 12-bit 200 MSPS digital to analog converter

1.2.2 Case outline(s). The case outline(s) are as specified herein.

<u>Outline letter</u>	<u>Number of pins</u>	<u>JEDEC PUB 95</u>	<u>Package style</u>
X	48	MS-026	Plastic quad flatpack

1.2.3 Lead finishes. The lead finishes are as specified below or other lead finishes as provided by the device manufacture:

<u>Finish designator</u>	<u>Material</u>
A	Hot solder dip
B	Tin-lead plate
C	Gold plate
D	Palladium
E	Gold flash palladium
F	Tin-lead alloy (BGA/CGA)
Z	Other

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1.3 Absolute maximum ratings. 1/

Supply voltage range:

( AVDD) .....	-0.5 V to 4.0 V 2/
(DVDD) .....	-0.5 V to 4.0 V 3/
Voltage between AGND and DGND .....	-0.5 V to 0.5 V
Voltage between AVDD and DVDD .....	-0.5 V to 0.5 V

Supply voltage range:

DA[11:0] and DB[11:0] .....	-0.5 V to DVDD + 0.5 V 3/
MODE, CLKA, CLKB, WRTA, WRTB .....	-0.5 V to DVDD + 0.5 V 3/
IOUTA1, IOUTA2, IOUTB1, IOUTB2 .....	-1.0 V to AVDD + 0.5 V 2/
EXTIO, BIASJ_A, BIASJ_B, SLEEP .....	-0.5 V to AVDD + 0.5 V 2/
Peak input current (any input) .....	20 mA
Peak total input current (all inputs) .....	-30 mA
Operating free-air temperature range ( TA ) .....	-55°C to +125°C
Storage temperature range (TSTG) .....	-65°C to 150°C
Lead temperature (1.6 mm (1/16 in) from the case for 10 seconds) .....	260°C
Package thermal characteristics, case X:	

Parameter	Thermal pad connected to printed circuit board (PCB) thermal plane
Thermal resistance, junction to ambient	63.7°C/W
Thermal resistance, junction to case	19.6°C/W

1/ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2/ Measured with respect to AGND.

3/ Measured with respect to DGND.

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2. APPLICABLE DOCUMENTS

JEDEC Solid State Technology Association

JEDEC PUB 95 – Registered and Standard Outlines for Semiconductor Devices

(Copies of these documents are available online at <https://www.jedec.org>.)

3. REQUIREMENTS

3.1 Marking. Parts shall be permanently and legibly marked with the manufacturer’s part number as shown in 6.3 herein and as follows:

- A. Manufacturer’s name, CAGE code, or logo
- B. Pin 1 identifier
- C. ESDS identification (optional)

3.2 Unit container. The unit container shall be marked with the manufacturer’s part number and with items A and C (if applicable) above.

3.3 Electrical characteristics. The maximum and recommended operating conditions and electrical performance characteristics are as specified in 1.3, 1.4, and table I herein.

3.4 Design, construction, and physical dimension. The design, construction, and physical dimensions are as specified herein.

3.5 Diagrams.

3.5.1 Case outline. The case outline shall be as shown in 1.2.2 and figure 1.

3.5.2 Terminal connections. The terminal connections shall be as shown in figure 2.

3.5.3 Function block diagram. The functional block diagram shall be as shown in figure 3.

3.5.4 Operating life derating chart. The operating life derating chart shall be as shown in figure 4.

<p><b>DEFENSE SUPPLY CENTER, COLUMBUS COLUMBUS, OHIO</b></p>	<p>SIZE <b>A</b></p>	<p>CODE IDENT NO. <b>16236</b></p>	<p>DWG NO. <b>V62/06651</b></p>
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TABLE I. Electrical performance characteristics. 1/

Test	Symbol	Conditions 2/	Limits		Unit
			Min	Max	
<b>DC Specifications</b>					
Resolution			12		Bits
<b>DC Accuracy</b> 3/					
Integral nonlinearity	INL	1 LSB = IOUTFS/2 <sup>12</sup> , TA = 25°C	-2	2	LSB
Differential nonlinearity	DNL		-2	2	LSB
<b>Analog output</b>					
Offset error			0.03 typical		%FSR
Gain error		With external reference	±0.25 typical		%FSR
		With internal reference	±0.5 typical		
Minimum full scale output current 4/			2 typical		mA
Maximum full scale output current 4/			20 typical		mA
Gain Mismatch		With internal reference	-2	2	%FSR
Output voltage compliance range 5/			-0.8	1.25	
Output resistance	RO		300 typical		kΩ
Output capacitance	CO		5 typical		pF
<b>Reference Output</b>					
Reference voltage			1.14	1.26	V
Reference output current 6/			100 typical		nA
<b>Reference Input</b>					
Input voltage	VEXTIO		0.1	1.25	V
Input resistance	RI		1 typical		MΩ
Small signal bandwidth			300 typical		kHz
Input capacitance	CI		100 typical		pF
<b>Temperature Coefficients</b>					
Offset drift			0 typical		7/
Gain drift		With external reference	±50 typical		7/
		With internal reference	±50 typical		
Reference voltage drift			±20 typical		ppm/°C

See footnotes at end of table.

<b>DEFENSE SUPPLY CENTER, COLUMBUS COLUMBUS, OHIO</b>	SIZE <b>A</b>	CODE IDENT NO. <b>16236</b>	DWG NO. <b>V62/06651</b>
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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions <u>8/</u>	Limits		Unit
			Min	Max	
<b>Power Supply</b>					
Analog supply voltage	AVDD		3.0	3.6	V
Digital supply voltage	DVDD		3.0	3.6	V
Supply current, analog	IAVDD	Including output current through load resistor		90	mA
		Sleep mode with clock		6	
		Sleep mode without clock	2.5 typical		
Supply current, digital	IDVDD			38	mA
		Sleep mode with clock		18	
		Sleep mode without clock	< 10 typical		
Power dissipation	PD			390	mW
		Sleep mode without clock	15 typical		
		fDATA = 200 MSPS, fOUT = 20 MHz	350 typical		
Analog power supply rejection ratio	APSRR		-0.2	0.2	%FSR/V
Digital power supply rejection ratio	DPSRR		-0.2	0.2	%FSR/V
Operating free air temperature	TA		-55	125	°C

See footnotes at end of table.

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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions 9/	Limits		Unit
			Min	Max	
<b>Analog Output</b>					
Maximum output update rate	fclk		200		MSPS
Output settling time to 0.1% (DAC)	ts	Mid scale transition	20 typical		ns
Output rise time 10% to 90% (OUT)	tr		1.4 typical		ns
Output fall time 90% to 10% (OUT)	tf		1.5 typical		ns
Output noise		IOUTFS = 20 mA	55 typical		pA/√Hz
		IOUTFS = 2 mA	30 typical		
<b>AC Linearity</b>					
Spurious free dynamic range	SFDR	1st Nyquist zone, TA = 25°C, fDATA = 50 MSPS, fOUT = 1 MHz, IOUTFS = 0 dB	81 typical		dBc
		1st Nyquist zone, TA = 25°C, fDATA = 50 MSPS, fOUT = 1 MHz, IOUTFS = -6 dB	83 typical		
		1st Nyquist zone, TA = 25°C, fDATA = 50 MSPS, fOUT = 1 MHz, IOUTFS = -12 dB	81 typical		
		1st Nyquist zone, TA = 25°C, fDATA = 100 MSPS, fOUT = 5 MHz	85 typical		
		1st Nyquist zone, TA = 25°C, fDATA = 100 MSPS, fOUT = 20 MHz	78 typical		
		1st Nyquist zone, TA = 25°C, fDATA = 200 MSPS, fOUT = 20 MHz	66		
		1st Nyquist zone, TA = -55°C to 125°C, fDATA = 200 MSPS, fOUT = 20 MHz	63		
		1st Nyquist zone, TA = 25°C, fDATA = 200 MSPS, fOUT = 41 MHz	68 typical		
Signal to noise ratio	SNR	1st Nyquist zone, TA = 25°C, fDATA = 100 MSPS, fOUT = 5 MHz	73 typical		dB
		1st Nyquist zone, TA = 25°C, fDATA = 200 MSPS, fOUT = 20 MHz	67 typical		
Adjacent channel leakage ratio	ACLR	W-CDMA signal with 3.84 MHz bandwidth, fDATA = 61.44 MSPS, IF = 15.36 MHz	70 typical		dB
		W-CDMA signal with 3.84 MHz bandwidth, fDATA = 122.88 MSPS, IF = 30.72 MHz	70 typical		
Third order two tone intermodulation	IMD3	Each tone at -6 dBFS, TA = 25°C, fDATA = 200 MSPS, fOUT = 45.4 MHz and 46.4 MHz	62 typical		dBc
		Each tone at -6 dBFS, TA = 25°C, fDATA = 100 MSPS, fOUT = 15.1 MHz and 16.1 MHz	78 typical		

See footnotes at end of table.

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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions <u>9/</u>	Limits		Unit
			Min	Max	
<b>AC Linearity – continued.</b>					
Four tone intermodulation	IMD	Each tone at -12 dBFS, TA = 25°C, fDATA = 100 MSPS, fOUT = 15.6, 15.8, 16.2, and 16.4 MHz	77 typical		dBc
		Each tone at -12 dBFS, TA = 25°C, fDATA = 165 MSPS, fOUT = 19, 19.1, 19.3, and 19.4 MHz	74 typical		
		Each tone at -12 dBFS, TA = 25°C, fDATA = 165 MSPS, fOUT = 68.8, 69.6, 71.2, and 72 MHz	56 typical		
Channel isolation		TA = 25°C, fDATA = 165 MSPS, fOUT(CH1) = 20 MHz, fOUT(CH2) = 21 MHz	97 typical		dBc

10/

**Digital Input**

High level input voltage	V <sub>IH</sub>		0.2	3.3	V
Low level input voltage	V <sub>IL</sub>		0	0.8	V
High level input current	I <sub>IH</sub>		±50 typical		µA
Low level input current	I <sub>IL</sub>		±10 typical		µA
High level input current. GSET pin	I <sub>IH</sub> (GSET)		7 typical		µA
Low level input current, . GSET pin	I <sub>IL</sub> (GSET)		-30 typical		µA
High level input current. MODE pin	I <sub>IH</sub> (MODE)		-30 typical		µA
Low level input current, . MODE pin	I <sub>IL</sub> (MODE)		-80 typical		µA
Input capacitance	C <sub>I</sub>		5 typical		pF

See footnotes at end of table.

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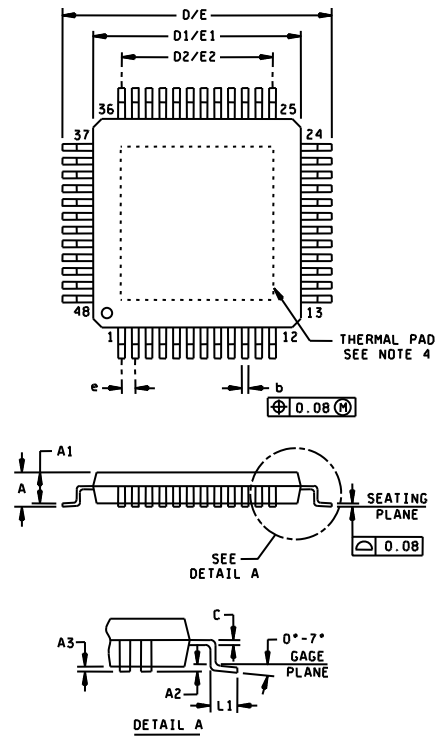
TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions <u>10/</u> - continued.	Limits		Unit
			Min	Max	
<b>Switching Characteristics</b>					
<b>Timing-Dual Bus Mode</b>					
Input setup time	t <sub>su</sub>		1		ns
Input hold time	t <sub>h</sub>		1		ns
Input clock pulse high time	t <sub>LPH</sub>		2 typical		ns
Clock latency (WRTA/B to outputs) <u>11/</u>	t <sub>LAT</sub>		4	4	clk
Propagation delay time	t <sub>PD</sub>		1.5 typical		ns
<b>Timing- Single Bus Interleaved Mode</b>					
Input setup time	t <sub>su</sub>		0.5 typical		ns
Input hold time	t <sub>h</sub>		0.5 typical		ns
Clock latency (WRTA/B to outputs) <u>11/</u>	t <sub>LAT</sub>		4	4	clk
Propagation delay time	t <sub>PD</sub>		1.5 typical		ns

- 1/ Testing and other quality control techniques are used to the extent deemed necessary to assure product performance over the specified temperature range. Product may not necessarily be tested across the full temperature range and all parameters may not necessarily be tested. In the absence of specific parametric testing, product performance is assured by characterization and/or design.
- 2/ Over operating free air temperature range, AVDD = DVDD = 3.3 V, IOUTFS = 20 mA, independent gain set mode (unless otherwise noted).
- 3/ Measured differentially through 50 Ω to AGND.
- 4/ Nominal full scale current, IOUTFS, equal 32x the IBIAS current.
- 5/ The lower limit of the output compliance is determined by the CMOS process. Exceeding this limit may result in transistor breakdown, resulting in reduced reliability of the device. The upper limit of the output compliance is determined by the load resistors and full-scale output current. Exceeding the upper limit adversely affects distortion performance and integral nonlinearity.
- 6/ Use an external buffer amplifier with high impedance input to drive any external load.
- 7/ ppm of FSR/°C.
- 8/ Over operating free air temperature range, AVDD = DVDD = 3.3 V, IOUTFS = 20 mA, fDATA = 200 MSPS, fOUT = 1 MHz, independent gain set mode (unless otherwise noted).
- 9/ AC specifications over operating free air temperature range, AVDD = DVDD = 3.3 V, IOUTFS = 20 mA, independent gain set mode, differential 1:1 impedance ratio transformer coupled output, 50 Ω doubly terminated load (unless otherwise noted).
- 10/ Digital specifications over operating free air temperature range, AVDD = DVDD = 3.3 V, IOUTFS = 20 mA, (unless otherwise noted).
- 11/ Specified by design.

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Case X



Dimension					
Symbol	Millimeters		Symbol	Millimeters	
	Min	Max		Min	Max
A		1.20	D/E	8.80	9.20
A1	0.95	1.05	D1/E1	6.80	7.20
A2	0.25 TYP		D2/E2	5.50 TYP	
A3	0.05		e	0.50 NOM	
b	0.17	0.27	L1	0.45	0.75
c	0.13 NOM				

NOTES:

1. This drawing is subject to change without notice.
2. Falls within JEDEC MS-026.

FIGURE 1. Case outline.

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Case X

Terminal number	Terminal symbol	Terminal number	Terminal symbol	Terminal number	Terminal symbol	Terminal number	Terminal symbol
1	DA11(MSB)	13	NC	25	DB9	37	SLEEP
2	DA10	14	NC	26	DB8	38	AGND
3	DA9	15	DGND	27	DB7	39	IOUTB1
4	DA8	16	DVDD	28	DB6	40	IOUTB2
5	DA7	17	WRTA/WRTIQ	29	DB5	41	BIASJ_B
6	DA6	18	CLKA/CLKIQ	30	DB4	42	GSET
7	DA5	19	CLKB/RESETIQ	31	DB3	43	EXTIO
8	DA4	20	WRTB/SELECTIQ	32	DB2	44	BIASJ_A
9	DA3	21	DGND	33	DB1	45	IOUTA2
10	DA2	22	DVDD	34	DB0(LSB)	46	IOUTA1
11	DA1	23	DB11(MSB)	35	NC	47	AVDD
12	DA0(LSB)	24	DB10	36	NC	48	MODE

NC: Not connected

FIGURE 2. Terminal connections.

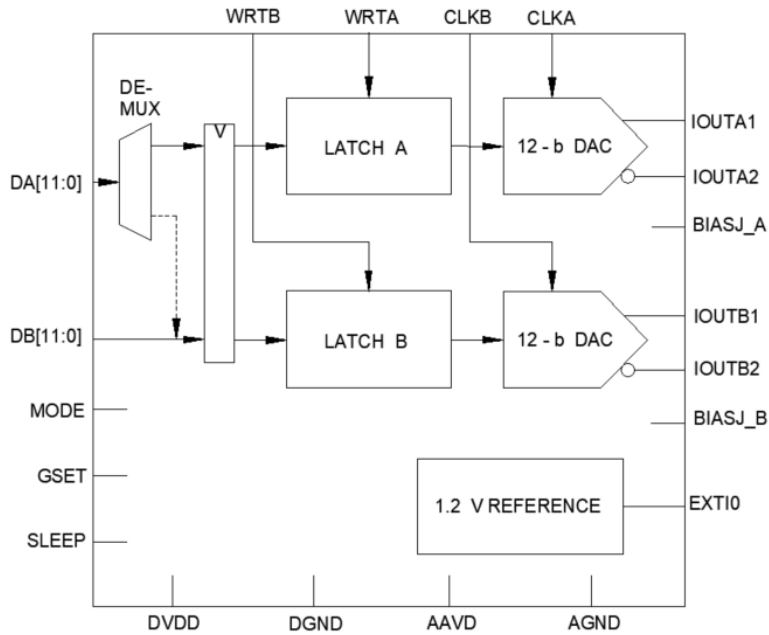


FIGURE 3. Functional block diagram.

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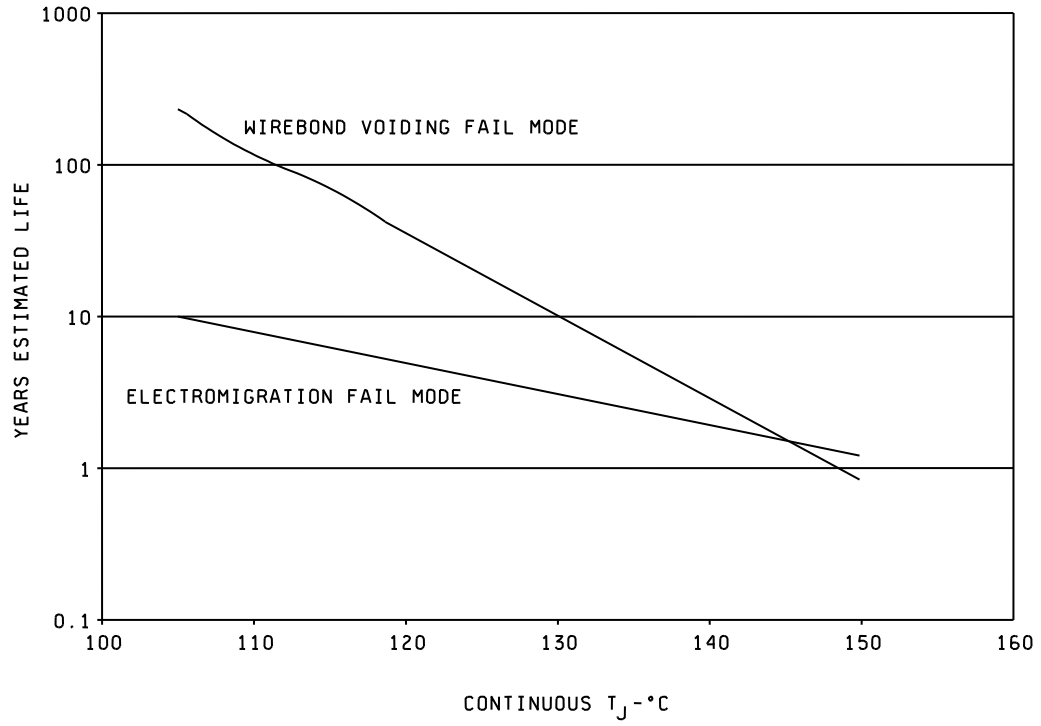


FIGURE 4. Operating life derating chart.

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4. VERIFICATION

4.1 Product assurance requirements. The manufacturer is responsible for performing all inspection and test requirements as indicated in their internal documentation. Such procedures should include proper handling of electrostatic sensitive devices, classification, packaging, and labeling of moisture sensitive devices, as applicable.

5. PREPARATION FOR DELIVERY

5.1 Packaging. Preservation, packaging, labeling, and marking shall be in accordance with the manufacturer's standard commercial practices for electrostatic discharge sensitive devices.

6. NOTES

6.1 ESDS. Devices are electrostatic discharge sensitive and are classified as ESDS class 1 minimum.

6.2 Configuration control. The data contained herein is based on the salient characteristics of the device manufacturer's data book. The device manufacturer reserves the right to make changes without notice. This drawing will be modified as changes are provided.

6.3 Suggested source(s) of supply. Identification of the suggested source(s) of supply herein is not to be construed as a guarantee of present or continued availability as a source of supply for the item. DLA Land and Maritime maintains an online database of all current sources of supply at <https://landandmaritimeapps.dla.mil/Programs/Smcr/>.

Vendor item drawing administrative control number <u>1/</u>	Device manufacturer CAGE code	Mode of transportation and quantity	Vendor part number
V62/06651-01XE	01295	Tape and reel, 1000 units	DAC5662MPFBREP
V62/06651-02XE	01295	Tape and reel, 250 units	DAC5662MPFBEP

1/ The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation.

CAGE code

01295

Source of supply

Texas Instruments, Inc.  
Semiconductor Group  
8505 Forest lane  
P.O. Box 660199  
Dallas, TX 75243

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